

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/718,430	JU ET AL.		
Examiner	Art Unit		
A. J. HEINZ	2627		

SEARCHED				
Subclass	Date	Examiner		
		·		
	Subclass	Subclass Date		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	12/7/06	174
See Search Strategy		
Consulted:		

Wednesday, December 06, 2006 9:28 PM
Cao, Allen; Castro, Angel; Chen, Tianjie; Evans, Jefferson;
William; Magee, Christopher; Mercedes, Dismerv E:
Mark; Davis, David; Kayrish, Matthew; Klimowicz,
SN 10/718430 Miller, Brian; Tupper, Robert; Blouin,

	٠.	j
	i	
-		
	-	
	·	
	L	